Search Notes			
	[[] [] [] [] [] [] [] [] [] [

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/816,855	OKANO, AKIHIRO	
Examiner	Art Unit	
Aaron M. Richer	2628	

SEARCHED				
Class	Subclass	Date	Examiner	
345	617	6/7/2006	AMR	
	_			

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated previous examiner's seach - EAST (USPGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) - see search history printout	6/7/2006	AMR